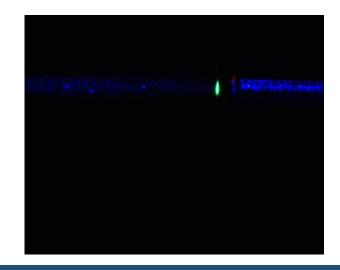
## **SiN with embedded QDots**



1.0 – 0.8 – 0.6 – 0.4 – 0.2 – 0.0 –

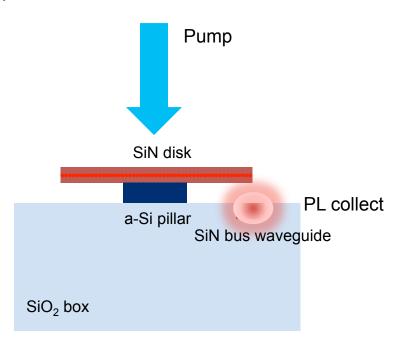
First demonstration ASE for SiN + QDOTs (core-shell CdSe/CdS)

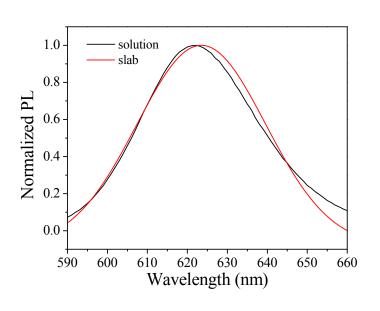


#### PL characterization

### Configuration of PL measurement

- 1. Pump with 400nm femtosecond laser on the top of disk (80MHz repetition rate, focused spot size ~ 100um diameter, ~200mW average power)
- 2. Collect the PL from the cleaved facet of on-chip bus waveguide using microlensed fiber



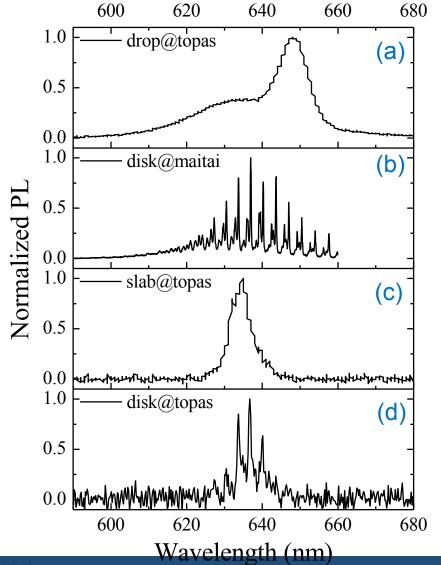


Cross-sectional schematics of PL measurement



### PL of SiN-QD disk

For disk pump on the top of disk and collect from the facet of waveguide



- (a) ASE meausurement on a drop cast film of QDs and pumping with a 1 kHz amplified system at 450nm (topas)
- (b) PL of the disk and pumping with 80 MHz Ti:Sapphire laser at 400nm (maitai)
- (c) PL of SiN/QD/SiN slab and pumping with topas at 450nm
- (d) PL of the disk and pumping with topas at 450nm

# **QDOT-amplifier status**

- Gain demonstrated in visible
- Next step: try again with HgTe QDOTS
- Electrically injected amplifier in processing

MS24 Demonstration of SPP amplifiers with electrical injection exhibiting 10dB/cm gain

## **Grating couplers**

- D5.7 Second generation beam shapers (distance 1mm, with bandwidth > 10nm and efficiency > 3dB)
- MS35 Fabrication of compact optical filters and first generation beam shapers
- → Samples delivered but still need to be measured (man power issue)